

**N-Channel Logic Level Enhancement Mode Field Effect Transistor**

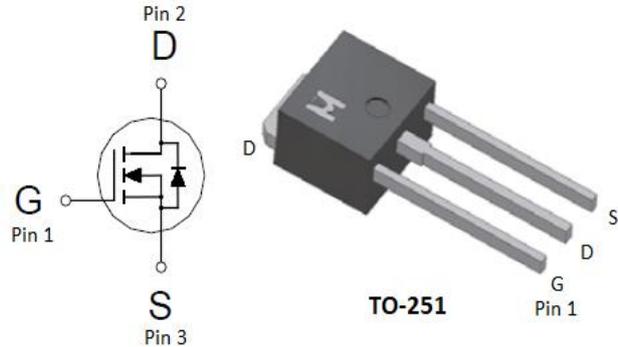
**Product Summary:**

|                                  |              |
|----------------------------------|--------------|
| $BV_{DSS}$                       | 100V         |
| $R_{DS(on) (MAX.) @V_{GS}=10V}$  | 12m $\Omega$ |
| $R_{DS(on) (MAX.) @V_{GS}=4.5V}$ | 15m $\Omega$ |
| $I_D @T_C=25^\circ C$            | 68A          |

Single N Channel MOSFET

UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



**ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ C$  Unless Otherwise Noted)**

| PARAMETERS/TEST CONDITIONS                     |                     | SYMBOL         | LIMITS     | UNIT       |
|--|---------------------|----------------|------------|------------|
| Gate-Source Voltage                            |                     | $V_{GS}$       | $\pm 20$   | V          |
| Continuous Drain Current                       | $T_C = 25^\circ C$  | $I_D$          | 68         | A          |
|  | $T_C = 100^\circ C$ |                | 43         |            |
| Pulsed Drain Current <sup>1</sup>              |                     | $I_{DM}$       | 150        |            |
| Avalanche Current                              |                     | $I_{AS}$       | 18         |            |
| Avalanche Energy                               | L = 0.1mH           | $E_{AS}$       | 16.2       | mJ         |
| Repetitive Avalanche Energy <sup>2</sup>       | L = 0.05mH          | $E_{AR}$       | 8.1        |            |
| Power Dissipation                              | $T_C = 25^\circ C$  | $P_D$          | 89         | W          |
|  | $T_C = 100^\circ C$ |                | 35         |            |
| Operating Junction & Storage Temperature Range |                     | $T_j, T_{stg}$ | -55 to 150 | $^\circ C$ |

**THERMAL RESISTANCE RATINGS**

| THERMAL RESISTANCE  | SYMBOL          | TYPICAL | MAXIMUM | UNIT           |
|---------------------|-----------------|---------|---------|----------------|
| Junction-to-Case    | $R_{\theta JC}$ |         | 1.4     | $^\circ C / W$ |
| Junction-to-Ambient | $R_{\theta JA}$ |         | 62.5    |                |

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle  $\leq 1\%$

<sup>3</sup>62.5 $^\circ C / W$  when mounted on a 1 in2 pad of 2 oz copper.



ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25 °C, Unless Otherwise Noted)

| PARAMETER   | SYMBOL                                 | TEST CONDITIONS   | LIMITS |      |      | UNIT |
|---|--|---|--------|------|------|------|
|   |  |   | MIN    | TYP  | MAX  |      |
| <b>STATIC</b>   |  |   |        |      |      |      |
| Drain-Source Breakdown Voltage  | V <sub>(BR)DSS</sub>                   | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA  | 100    |      |      | V    |
| Gate Threshold Voltage  | V <sub>GS(th)</sub>                    | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA                                  | 1.0    | 2.0  | 3.0  |      |
| Gate-Body Leakage   | I <sub>GSS</sub>                       | V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±12V  |        |      | ±100 | nA   |
| Zero Gate Voltage Drain Current   | I <sub>DSS</sub>                       | V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V   |        |      | 1    | μA   |
|   |  | V <sub>DS</sub> = 70V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125 °C                        |        |      | 25   |      |
| On-State Drain Current <sup>1</sup>   | I <sub>D(ON)</sub>                     | V <sub>DS</sub> = 5V, V <sub>GS</sub> = 10V   | 68     |      |      | A    |
| Drain-Source On-State Resistance <sup>1</sup>                                 | R <sub>DS(ON)</sub>                    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 12A   |        | 9.5  | 12   | mΩ   |
|   |  | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 10A  |        | 11.5 | 15   |      |
| Forward Transconductance <sup>1</sup>   | g <sub>fs</sub>                        | V <sub>DS</sub> = 5V, I <sub>D</sub> = 12A  |        | 45   |      | S    |
| <b>DYNAMIC</b>  |  |   |        |      |      |      |
| Input Capacitance   | C <sub>iss</sub>                       | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 50V, f = 1MHz                                       |        | 2130 |      | pF   |
| Output Capacitance  | C <sub>oss</sub>                       |   |        | 336  |      |      |
| Reverse Transfer Capacitance  | C <sub>rss</sub>                       |   |        | 29   |      |      |
| Gate Resistance   | R <sub>g</sub>                         | V <sub>GS</sub> = 15mV, V <sub>DS</sub> = 0V, f = 1MHz                                      |        | 1.5  |      | Ω    |
| Total Gate Charge <sup>1,2</sup>  | Q <sub>g</sub> (V <sub>GS</sub> =10V)  | V <sub>DS</sub> = 50V, V <sub>GS</sub> = 10V,<br>I <sub>D</sub> = 12A                       |        | 38   |      | nC   |
|   | Q <sub>g</sub> (V <sub>GS</sub> =4.5V) |   |        | 23   |      |      |
| Gate-Source Charge <sup>1,2</sup>   | Q <sub>gs</sub>                        |   |        | 10   |      |      |
| Gate-Drain Charge <sup>1,2</sup>  | Q <sub>gd</sub>                        |   |        | 8.2  |      |      |
| Turn-On Delay Time <sup>1,2</sup>   | t <sub>d(on)</sub>                     | V <sub>DS</sub> = 50V,<br>I <sub>D</sub> = 12A, V <sub>GS</sub> = 10V, R <sub>GS</sub> = 6Ω |        | 6    |      | nS   |
| Rise Time <sup>1,2</sup>  | t <sub>r</sub>                         |   |        | 10   |      |      |
| Turn-Off Delay Time <sup>1,2</sup>  | t <sub>d(off)</sub>                    |   |        | 8    |      |      |
| Fall Time <sup>1,2</sup>  | t <sub>f</sub>                         |   |        | 25   |      |      |
| <b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>C</sub> = 25 °C)</b> |  |   |        |      |      |      |
| Continuous Current  | I <sub>S</sub>                         |   |        |      | 68   | A    |
| Pulsed Current <sup>3</sup>   | I <sub>SM</sub>                        |   |        |      | 150  |      |
| Forward Voltage <sup>1</sup>  | V <sub>SD</sub>                        | I <sub>F</sub> = 12A, V <sub>GS</sub> = 0V  |        |      | 1.2  | V    |
| Reverse Recovery Time   | t <sub>rr</sub>                        | I <sub>F</sub> = 12A, dI <sub>F</sub> /dt = 100A / μS                                       |        | 30   |      | nS   |
| Reverse Recovery Charge   | Q <sub>rr</sub>                        |   |        |      | 130  |      |

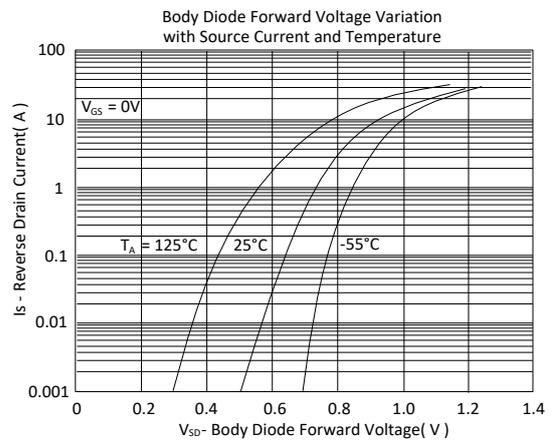
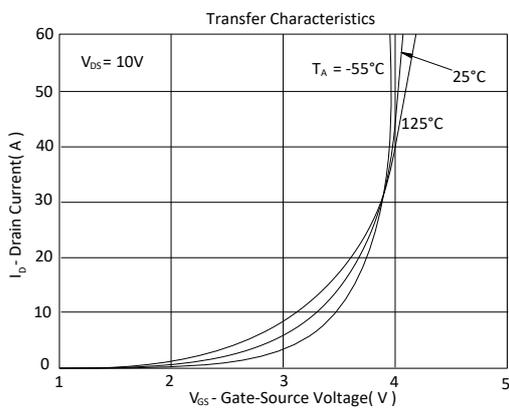
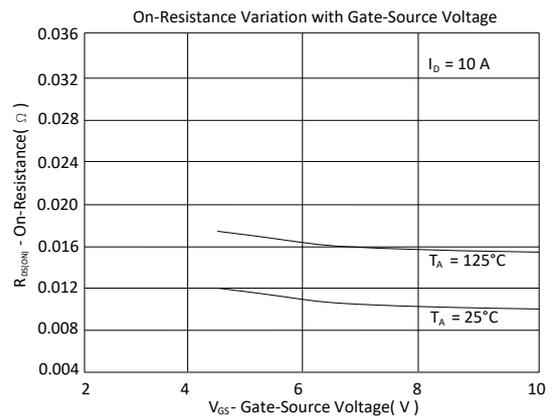
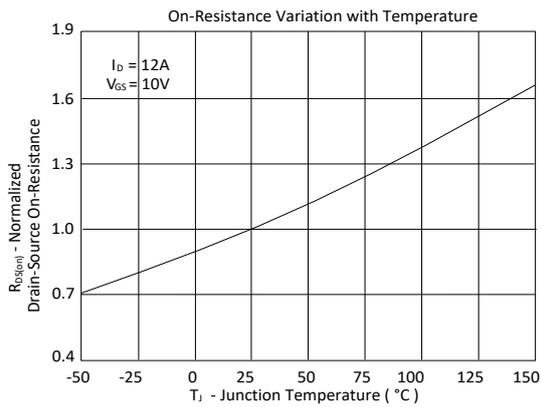
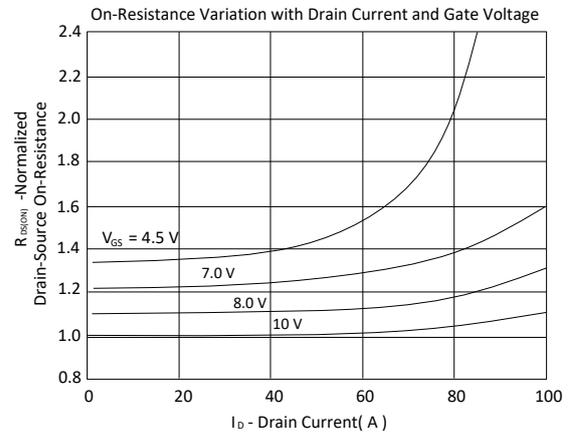
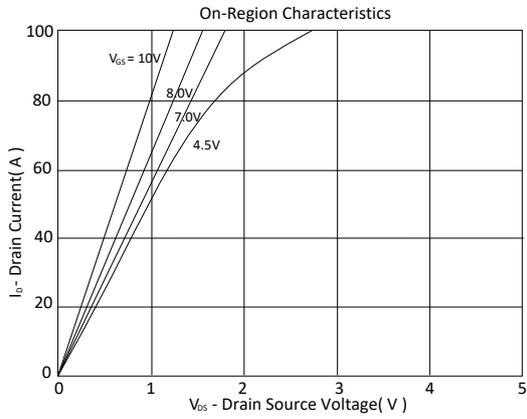
<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu\text{sec}$ , Duty Cycle  $\leq 2\%$ .

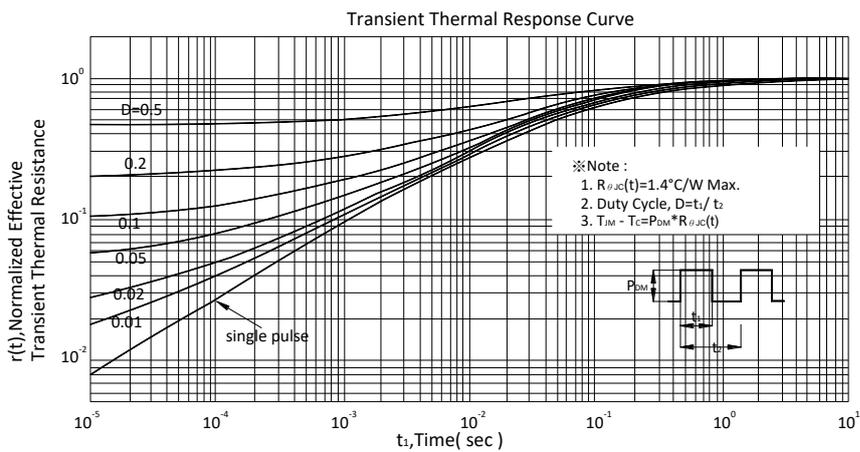
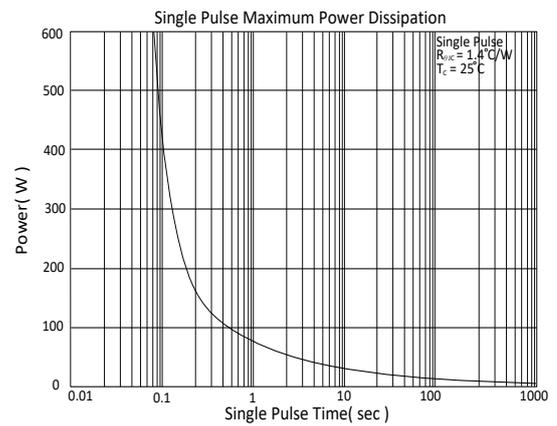
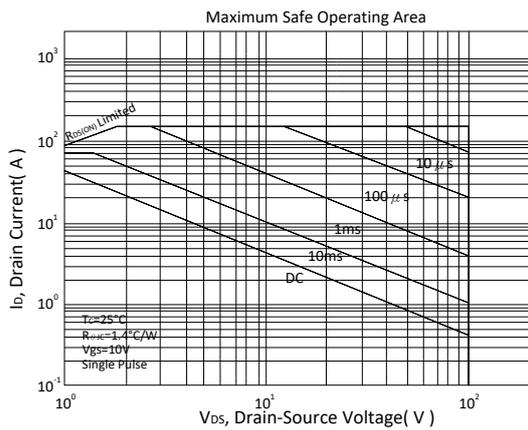
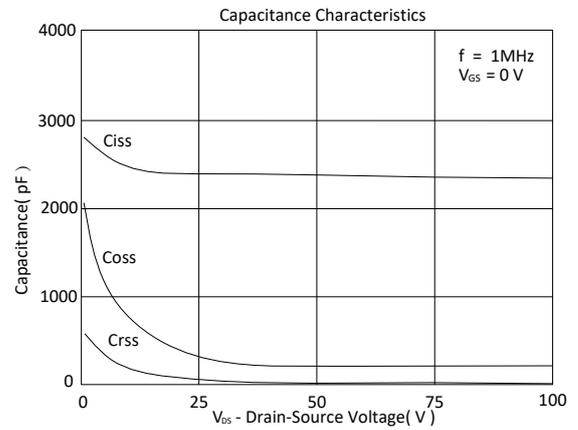
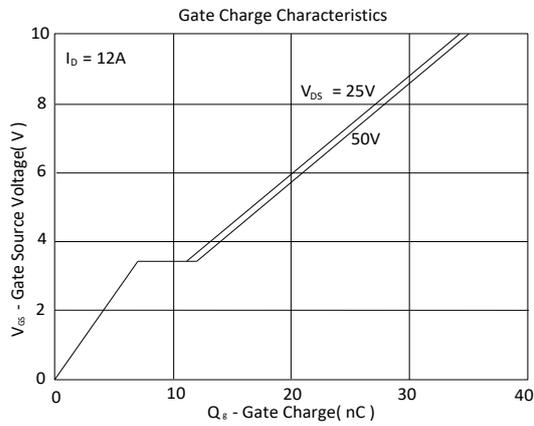
<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.

EMC will review datasheet by quarter, and update new version.

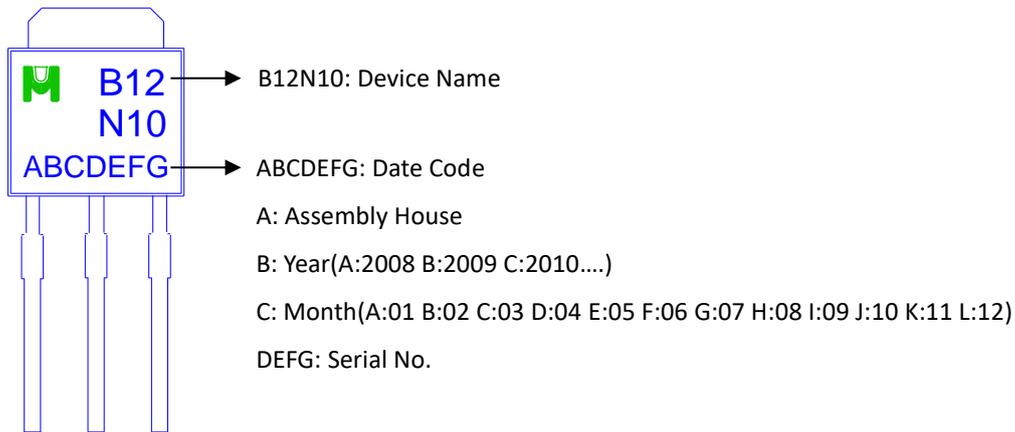
TYPICAL CHARACTERISTICS



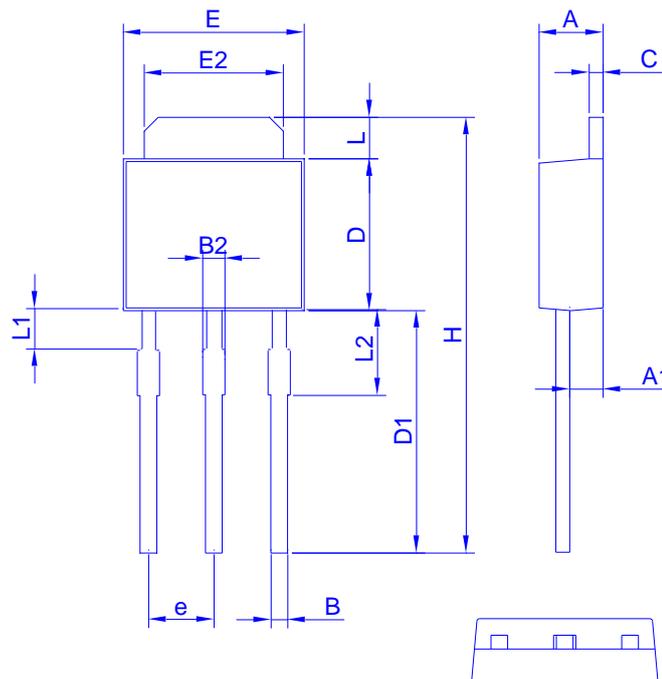


Ordering & Marking Information:

Device Name: EMB12N10CL for IPAK (TO-251)



Outline Drawing

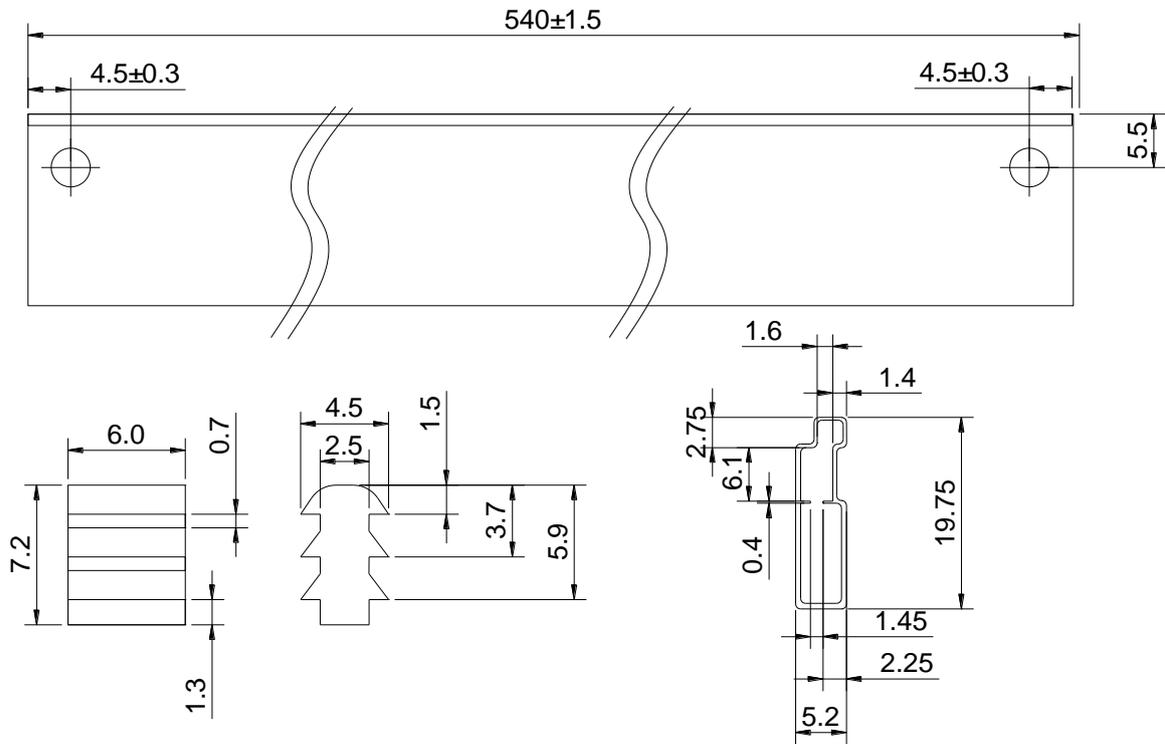


Dimension in mm

| Dimension | A    | A1   | B    | B2   | C    | D    | D1   | E    | E2   | H     | L    | L1   | L2   | e    |
|-----------|------|------|------|------|------|------|------|------|------|-------|------|------|------|------|
| Min.      | 2.18 | 0.89 | 0.64 | 0.91 | 0.46 | 5.33 | 7.00 | 6.35 | 4.95 | 13.22 | 0.89 | 0.94 | 1.91 | -    |
| Typ.      | 2.29 | 1.02 | 0.76 | 1.03 | 0.67 | 5.78 | 8.33 | 6.54 | 5.21 | 15.18 | 1.08 | 1.23 | 2.10 | 2.29 |
| Max.      | 2.39 | 1.14 | 0.89 | 1.14 | 0.89 | 6.22 | 9.65 | 6.73 | 5.46 | 17.14 | 1.27 | 1.52 | 2.29 | -    |



◆ TO-251 Tube Information: 75pcs/Tube (Dimension in millimeter)



|        |          |
|--------|----------|
| 產品別    | TO-251   |
| 底塞顏色   | 白        |
| 端塞顏色   | 藍        |
| 裝管方向   | Pin 孔朝底塞 |
| 裝箱數    |          |
| 滿管數量   | 75       |
| 管/內盒比  | 50:1     |
| 內盒滿箱數  | 3.75K    |
| 內盒/外箱比 | 4:1      |
| 外箱滿箱數  | 15K      |